Ordering number : ENN6572

2SB817P : PNP Epitaxial Planar Silicon Transistor
2SD1047P : NPN Triple Diffused Planar Silicon Transistor

2SB817P / 2SD1047P

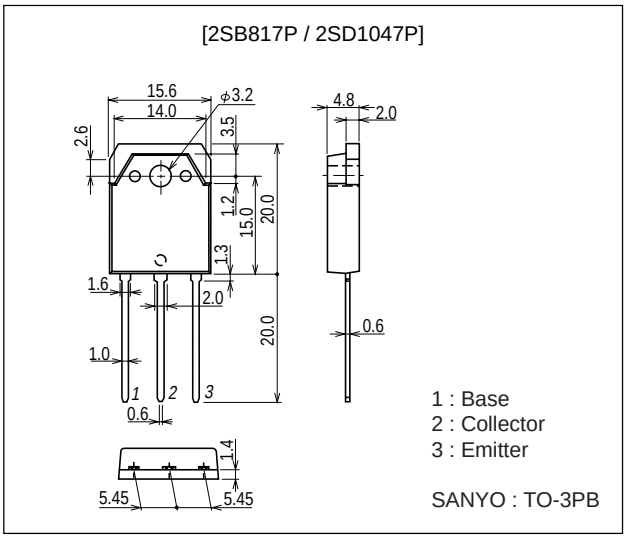
140V / 12A, AF80W Output Applications

Features

- Capable of being mounted easily because of one-point fixing type plastic molded package (Inter-changeable with TO-3).
- Wide ASO because of built-in ballast resistance.
- Goode dependence of f_T on current and good HF characteristic.

Package Dimensions

unit : mm
2022A



Specifications

( ) : 2SB817P

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	V_{CBO}		(–)160	V
Collector-to-Emitter Voltage	V_{CEO}		(–)140	V
Emitter-to-Base Voltage	V_{EBO}		(–)6	V
Collector Current	I_C		(–)12	A
Collector Current (Pulse)	I_{CP}		(–)15	A
Collector Dissipation	P_C	Tc=25°C	120	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		–40 to +150	°C

Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector Cutoff Current	I_{CBO}	V_{CB}=(-)80V, I_E=0			(-)0.1	mA
Emitter Cutoff Current	I_{EBO}	V_{EB}=(-)4V, I_C=0			(-)0.1	mA

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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
DC Current Gain	$h_{FE}1$	V_{CE}=(-)5V, I_C=(-)1A	60*		200*	
	$h_{FE}2$	V_{CE}=(-)5V, I_C=(-)6A	20			
Gain-Bandwidth Product	f_T	V_{CE}=(-)5V, I_C=(-)1A		15		MHz
Output Capacitance	Cob	V_{CB}=(-)10V, f=1MHz		(300)210		pF
Base-to-Emitter Saturation Voltage	V_{BE}	V_{CE}=(-)5V, I_C=(-)1A			1.5	V
Collector-to-Emitter Saturation Voltage	V_{CE}(sat)	I_C=(-)5A, I_B=(-)0.5A		(1.1)0.6	2.5	V
Collector-to-Base Breakdown Voltage	$V_{(BR)CBO}$	I_C=(-)5mA, I_E=0	(-)160			V
Collector-to-Emitter Breakdown Voltage	$V_{(BR)CEO}$	I_C=(-)5mA, R_{BE}=∞	(-)140			V
		I_C=(-)50mA, R_{BE}=∞	(-)140			V
Emitter-to-Base Breakdown Voltage	$V_{(BR)EBO}$	I_E=(-)5mA, I_C=0	(-)6			V
Turn-ON Time	t_{on}	See specified test circuit.		(0.25)0.26		μs
Fall Time	t_f	See specified test circuit.		(0.53)0.68		μs
Storage Time	t_{stg}	See specified test circuit.		(1.61)6.88		μs

* : The 2SB817P / 2SD1047P are classified by 1A h_{FE} as follows

Rank	D	E
h_{FE}	60 to 120	100 to 200

Swicthing Time Test Circuit